

## **Notice of References Cited**

Application/Control No. 09/752,392	Applicant(s)/Patent Under Reexamination OLSON ET AL.		
Examiner	 Art Unit		
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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6445801 - B1 -	09-2002	Pastor et al.	381/94.2
	В	US-6094464 - A	07-2000	Ebringer et al.	375/342
	С	US-5999282 - A	12-1999	Suzuki et al.	359/20
	D	US-5960029 - A X	09-1999	Kim et al.	375/140
	Е	US-5844596 - A	12-1998	Goodman	348/14.02
	F	US-5717713 - A	02-1998	Natali	375/149
	G	US-5563664 - A	10-1996	Yang et al.	348/475
	Н	US-5487120 - A	01-1996	Choy et al.	385/24
	1	US-5384725 - A	01-1995	Coifman et al.	708/801
	J	US-5007705 - A	04-1991	Morey et al.	385/12
	к	US-4370648 - A	01-1983	Wagner et al.	340/825.2
	L	US-3771072 - A	11-1973	Slobodnik, Jr.	333/155
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP - 09055693 - A	02-1997	Japan	Masui et al.	
	0	WO - 200150663 - A	07-2001	AE, AL, etc	Choi et al.	
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

HON-I ATEN BOOMEN			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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	х		

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